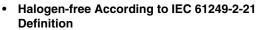


# NCEP4085EG-VB Datasheet N-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)		
40	0.0025 at V <sub>GS</sub> = 10 V	120	38 nC		
40	$0.0028$ at $V_{GS} = 6.5 \text{ V}$	105	30 110		

#### **FEATURES**



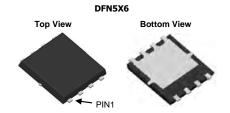


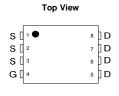
COMPLIANT

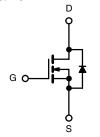
- TrenchFET® Power MOSFET
- 100 % R<sub>g</sub> Tested
- 100 % UIS Tested

### **APPLICATIONS**

- Synchronous Rectification
- Secondary Side DC/DC







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	$I_A = 25  ^{\circ}\text{C}$ , unles	ss otherwise not	ed		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	40	v		
Gate-Source Voltage	V <sub>GS</sub>	± 20			
	T <sub>C</sub> = 25 °C		120		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	$T_C = 70  ^{\circ}C$	I <sub>D</sub>	80		
Continuous Brain Current (1) = 100 °C)	T <sub>A</sub> = 25 °C	υ υ	33 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		26 <sup>b, c</sup>	Α	
Pulsed Drain Current		I <sub>DM</sub>	360		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	100		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	'S	4.9 <sup>b, c</sup>		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	40		
Single Pulse Avalanche Energy	L = 0.1 IIII	E <sub>AS</sub>	80	mJ	
	T <sub>C</sub> = 25 °C		83		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	53	w	
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C	' b	5.4 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		3.4 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150		
Soldering Recommendations (Peak Temperature		260	°C		

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	$R_{thJA}$	18	23	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	1.0	1.5	5/ <b>VV</b>		

- a. Based on T<sub>C</sub> = 25 °C. b. Surface mounted on 1" x 1" FR4 board.
- d. Maximum under steady state conditions is 90 °C/W.
- e. Calculated based on maximum junction temperature. Package limitation current is 80 A.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						1
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$	40			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		43		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	l <sub>D</sub> = 250 μA		- 6		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zone Ooto Vellana Busin Oomaal	1	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V			1	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	100			Α
	_	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		0.0025		Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 6.5 \text{ V}, I_D = 20 \text{ A}$		0.0028		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A		102		S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>			4750		pF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, f = 1 MHz		610		
Reverse Transfer Capacitance	C <sub>rss</sub>			275		
Total Cata Chausa		$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$		78	117	nC
Total Gate Charge	Qg			38	57	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		13		
Gate-Drain Charge	Q <sub>gd</sub>			11		
Gate Resistance	$R_g$	f = 1 MHz	0.2	0.7	1.4	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			14	25	ns
Rise Time	t <sub>r</sub>	$V_{DD} = 20 \text{ V}, R_L = 2 \Omega$		9	18	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		41	65	
Fall Time	t <sub>f</sub>			9	18	
Turn-On Delay Time	t <sub>d(on)</sub>			33	42	113
Rise Time	t <sub>r</sub>	$V_{DD} = 20 \text{ V}, R_L = 2 \Omega$		22	35	_
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		42	65	
Fall Time	t <sub>f</sub>			13	25	
<b>Drain-Source Body Diode Characteris</b>	stics					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C		50		Α
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			60		
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 5 A		0.75	1.1	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			40	60	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 10 A, dl/dt = 100 A/μs, T <sub>.l</sub> = 25 °C		48	72	nC
Reverse Recovery Fall Time	t <sub>a</sub>	1 <sub>F</sub> = 10 Λ, αι/αι = 100 Λ/μ5, 1 <sub>J</sub> = 25 0		24		20
Reverse Recovery Rise Time	t <sub>b</sub>			16		ns

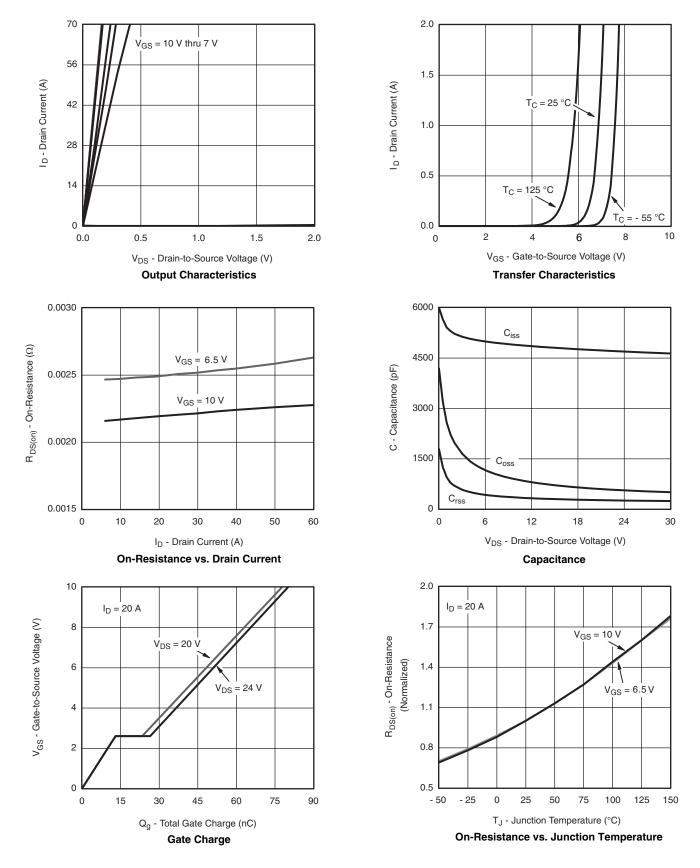
#### Notes

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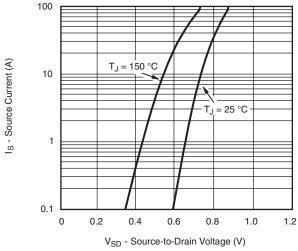
- a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

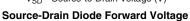
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

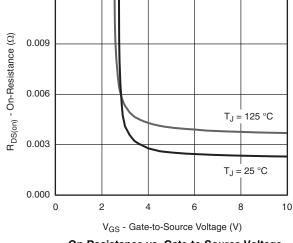






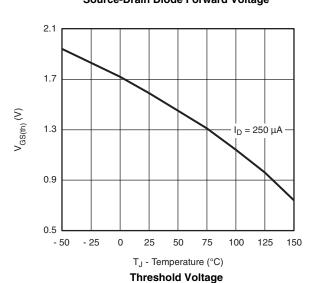


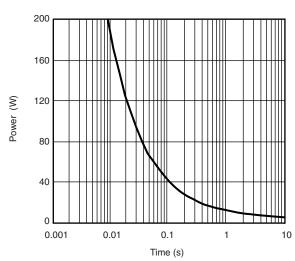




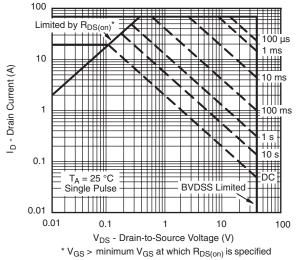
0.012

On-Resistance vs. Gate-to-Source Voltage



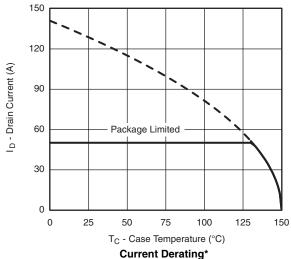


Single Pulse Power, Junction-to-Ambient

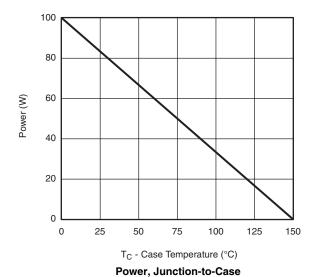


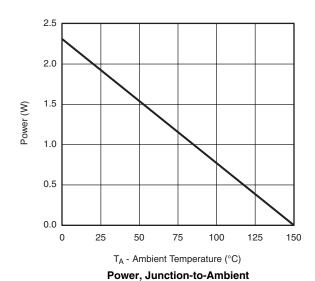
Safe Operating Area, Junction-to-Ambient





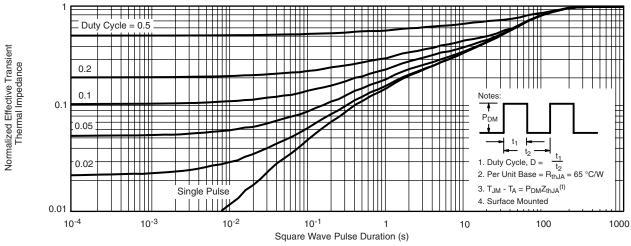


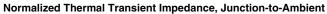


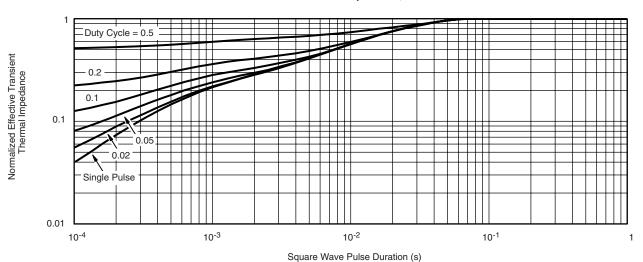


 $<sup>^*</sup>$  The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





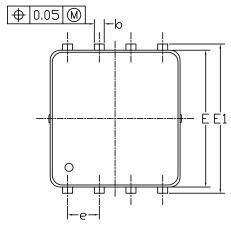


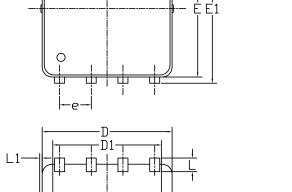


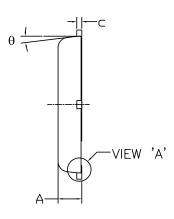
Normalized Thermal Transient Impedance, Junction-to-Case

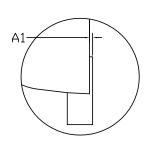


DFN5x6\_8L\_EP1\_P PACKAGE OUTLIN

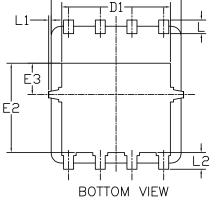


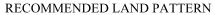


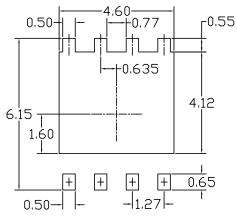




VIEW 'A' (SCALE 5:1)







SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.85	0. 95	1.00	0.033	0.037	0.039	
A1	0.00		0.05	0.000		0.002	
b	0.30	0.40	0.50	0.012	0.016	0.020	
c	0. 15	0. 20	0. 25	0.006	0.008	0.010	
D	5. 10	5. 20	5. 30	0. 201	0. 205	0. 209	
D1	4. 25	4. 35	4. 45	0. 167	0.171	0. 175	
Е	5. 45	5. 55	5. 65	0. 215	0. 219	0. 222	
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242	
E2	3. 525	3. 625	3. 725	0. 139	0. 143	0. 147	
E3	1. 175	1. 275	1. 375	0.046	0.050	0.054	
e	1. 27 BSC			0.050 BSC			
L	0.45	0. 55	0.65	0.018	0.022	0.026	
L1	0		0.15	0		0.006	
L2	0.68 REF			0. 027 REF			
θ	0°		10°	0°		10°	

#### UNIT: mm **NOTE**

- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



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